Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/531,005	CHOI ET AL.
Examiner	Art Unit
Le Nguyen	2174

SEARCHED				
Class	Subclass	Date	Examiner	
715	827	11/2/2005	LVN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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US-PGPub: 345/172; 715/827		11/2/2005	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPG-Pub; USPAT: 715/716-720,711,783,810,834-838,840,847,805,825,826; 348/14.05,14.03	11/2/2005	LVN